

Notice of References Cited

Application/Control No.

10/606,624

Applicant(s)/Patent Under
Reexamination
OBERST, SHAWN

Examiner

David Garcia Cervetti

Art Unit

2436

Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,649,099 A	07-1997	Theimer et al.	726/4
*	B	US-5,918,015 A	06-1999	Suzuki et al.	709/219
*	C	US-6,023,765 A	02-2000	Kuhn, D. Richard	726/4
*	D	US-6,044,466 A	03-2000	Anand et al.	726/1
*	E	US-6,047,377 A	04-2000	Gong, Li	726/21
*	F	US-6,138,238 A	10-2000	Scheffler et al.	726/17
*	G	US-6,192,476 B1	02-2001	Gong, Li	726/4
*	H	US-6,202,066 B1	03-2001	Barkley et al.	707/9
*	I	US-6,279,111 B1	08-2001	Jensenworth et al.	726/10
*	J	US-6,389,540 B1	05-2002	Scheffler et al.	726/21
*	K	US-2002/0062451 A1	05-2002	Scheidt et al.	713/201
*	L	US-6,397,336 B2	05-2002	Leppek, James	726/4
*	M	US-6,412,070 B1	06-2002	Van Dyke et al.	726/17

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/606,624

Applicant(s)/Patent Under
Reexamination
OBERST, SHAWN

Examiner

David Garcia Cervetti

Art Unit

2436

Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,427,228 B1	07-2002	Wigger, William Daniel	717/111
*	B	US-2002/0157023 A1	10-2002	Callahan et al.	713/201
*	C	US-2002/0147801 A1	10-2002	Gullotta et al.	709/223
*	D	US-2003/0079120 A1	04-2003	Hearn et al.	713/150
*	E	US-2003/0084325 A1	05-2003	Koved et al.	713/200
*	F	US-2003/0084324 A1	05-2003	Koved et al.	713/200
*	G	US-2003/0163479 A1	08-2003	Mathews et al.	707/102
*	H	US-2003/0154403 A1	08-2003	Keinsley et al.	713/201
*	I	US-2003/0196108 A1	10-2003	Kung, Kenneth C.	713/200
*	J	US-2003/0208378 A1	11-2003	Thangaraj et al.	705/2
*	K	US-2004/0019546 A1	01-2004	Ta et al.	705/35
*	L	US-2004/0064528 A1	04-2004	Meredith et al.	709/219
*	M	US-2004/0083243 A1	04-2004	Feng et al.	707/203

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/606,624		Applicant(s)/Patent Under Reexamination OBERST, SHAWN	
	Examiner David Garcia Cervetti		Art Unit 2436	Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0103339 A1	05-2004	Chalasani et al.	714/004
*	B	US-6,754,884 B1	06-2004	Lucas et al.	717/108
*	C	US-2004/0139319 A1	07-2004	Favazza et al.	713/168
*	D	US-6,772,350 B1	08-2004	Belani et al.	726/2
*	E	US-2004/0181453 A1	09-2004	Ray et al.	705/016
*	F	US-2004/0193909 A1	09-2004	Chang et al.	713/200
*	G	US-2004/0267746 A1	12-2004	Marcjan et al.	707/008
*	H	US-2005/0015491 A1	01-2005	Koeppel, Arthur	709/226
*	I	US-6,944,777 B1	09-2005	Belani et al.	713/150
*	J	US-6,947,989 B2	09-2005	Gullotta et al.	709/226
*	K	US-2005/0273772 A1	12-2005	Matsakis et al.	717/136
*	L	US-6,985,955 B2	01-2006	Gullotta et al.	709/229
*	M	US-2006/0101071 A1	05-2006	Henderson, Charles E.	707/104.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/606,624

Applicant(s)/Patent Under
Reexamination
OBERST, SHAWN

Examiner

David Garcia Cervetti

Art Unit

2436

Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,080,384 B2	07-2006	Wall et al.	719/316
*	B	US-7,117,448 B2	10-2006	Cooper et al.	715/764
*	C	US-7,305,432 B2	12-2007	Feng et al.	709/203
*	D	US-7,359,884 B2	04-2008	Ta et al.	705/59
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.